

## CDCVF25081 3.3-V Phased-Lock Loop Clock Driver

### 1 Features

- Phase-locked loop based, zero-delay buffer
  - 1 clock input to 2 banks of 4 outputs
  - No external RC network required
- Supply voltage: 3 V to 3.6 V
- Operating frequency: 8 MHz to 200 MHz
- Low additive jitter (cycle-cycle):  $\pm 100$  ps for 66 MHz to 200 MHz
- Power-down mode available
  - Current consumption:  $< 20$   $\mu$ A in Power-down mode
- 25- $\Omega$  on-chip series damping resistors
- Industrial temperature range:  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$
- Spread Spectrum Clock Compatible (SSC)
- Packaged in
  - 9.9-mm  $\times$  3.91-mm, 16-pin SOIC (D)
  - 5.0-mm  $\times$  4.4-mm, 16-pin TSSOP (PW)

### 2 Applications

- Defense radio
- Production switchers and mixers
- Radar
- In-vitro diagnostics
- CT & PET scanner

### 3 Description

The CDCVF25081 is a high performance, low skew, low jitter, phased-locked loop clock driver. It uses a PLL to precisely align, in both frequency and phase, the output clocks to the input clock signal. The outputs are divided into 2 banks for a total of 8 buffered CLKIN outputs. The device automatically puts the outputs to a low state when no CLKIN signal is present (power down mode).

The S1 and S2 pins allow selection between PLL or bypassed PLL outputs. When left open, the outputs are disabled to a logic low state.

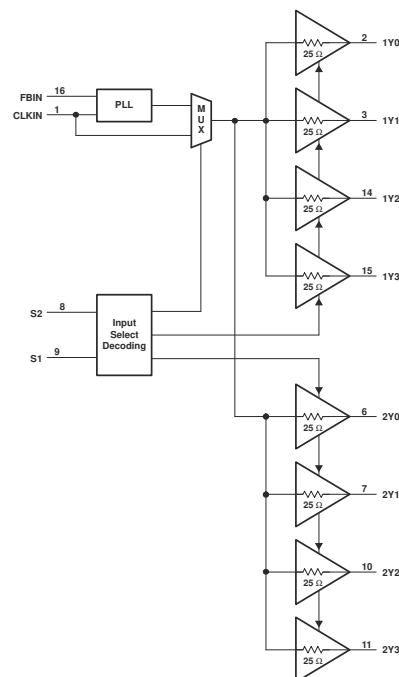
The part supports a fail-safe function. The device further incorporates an input hysteresis which prevents random oscillation of the outputs in the absence of an input signal.

The device operates in 3.3V supply environment and is characterized from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$  (ambient temperature).

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
CDCVF25081	SOIC (16)	9.90 mm $\times$ 3.91 mm
	TSSOP (16)	5.00 mm $\times$ 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.



**Functional Block Diagram**



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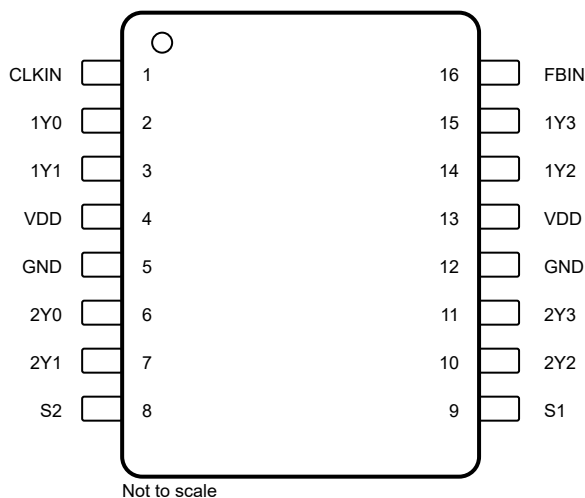
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## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

<b>Changes from Revision A (February 2003) to Revision B (January 2022)</b>	<b>Page</b>
• Updated the numbering format for tables, figures, and cross-references throughout the document.....	<b>1</b>
• Added <i>ESD Ratings</i> table, <i>Thermal Information</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section.....	<b>1</b>

## 5 Pin Configuration and Functions



**Figure 5-1. D or PW Package 16-Pin SOIC or TSSOP Top View**

**Table 5-1. Pin Functions**

PIN		I/O TYPE <sup>(1)</sup>	DESCRIPTION
NAME	NO.		
INPUT CLOCK			
CLKIN	1	I	Clock input. CLKIN must have a fixed frequency and phase in order for the PLL to acquire lock. Once the circuit is powered up and a valid signal is applied, a stabilization time is required for the PLL to phase lock the feedback signal to CLKIN.
INPUT SELECT			
S1, S2	9, 8	I	Input Selection. Selects input port. (See <a href="#">Table 8-2.</a> )
FEEDBACK			
FBIN	16	I	Feedback input. FBIN provides the feedback signal to the internal PLL. FBIN must be wired to one of the outputs to complete the feedback loop of the internal PLL. The integrated PLL synchronizes the FBIN and output signal so there is nominally zero-delay from input clock to output clock.
OUTPUT CLOCKS			
1Y0	2	O	Bank 1 Y0 clock output with an integrated 25-Ω series-damping resistor.
1Y1	3	O	Bank 1 Y1 clock output with an integrated 25-Ω series-damping resistor.
1Y2	14	O	Bank 1 Y2 clock output with an integrated 25-Ω series-damping resistor.
1Y3	15	O	Bank 1 Y3 clock output with an integrated 25-Ω series-damping resistor.
2Y0	6	O	Bank 2 Y0 clock output with an integrated 25-Ω series-damping resistor.
2Y1	7	O	Bank 2 Y1 clock output with an integrated 25-Ω series-damping resistor.
2Y2	10	O	Bank 2 Y2 clock output with an integrated 25-Ω series-damping resistor.
2Y3	11	O	Bank 2 Y3 clock output with an integrated 25-Ω series-damping resistor.
SUPPLY VOLTAGE AND GROUND			
VDD	4, 13	P	3.3V power supply for output channels and core voltage.
GND	5, 12	G	Ground. Connect ground pad to system ground.

(1) The definitions below define the I/O type for each pin.

- I = Input
- O = Output
- P = Power Supply
- G = Ground

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
$V_{DD}$	Power supply voltage	-0.5	4.6	V
$V_I$	Input voltage range <sup>(2) (3)</sup>	-0.5	4.6	V
$V_O$	Output voltage range <sup>(2) (3)</sup>	-0.5	$V_{DD} + 0.5$	V
$I_{IK}$	Input clamp current ( $V_I < 0$ )	-50		mA
$I_{OK}$	Output clamp current ( $V_O < 0$ )	-50		mA
$I_O$	Continuous total output current ( $V_O = 0$ to $V_{DD}$ )	-50		mA
$\theta_{JA}$	Package thermal impedance <sup>(4)</sup>		147	°C/W
	PW package		112	°C/W
$T_{stg}$	Storage temperature	-65	150	°C

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (3) This value is limited to 4.6 V maximum.
- (4) The package thermal impedance is calculated in accordance with JESD 51.

### 6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	±2000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup>	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

	MIN	NOM	MAX	UNIT
Supply voltage, $V_{DD}$	3	3.3	3.6	V
Low level input voltage, $V_{IL}$			0.8	V
High level input voltage, $V_{IH}$	2			V
Input voltage, $V_I$	0		3.6	V
High-level output current, $I_{OH}$			-12	mA
Low-level output current, $I_{OL}$			12	mA
Operating free-air temperature, $T_A$	-40		85	°C

## 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		CDCVF25081		UNIT
		SOIC (D)	TSSOP (PW)	
		16 PINS	16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	87.5	109.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	46.0	40.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	46.2	56.1	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	11.7	3.6	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	45.8	55.6	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report (SPRA953).

## 6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IK</sub>	Input voltage	V <sub>DD</sub> = 3 V, I <sub>I</sub> = −18 mA			−1.2	V
I <sub>I</sub>	Input current	V <sub>I</sub> = 0 V or V <sub>DD</sub>			±5	μA
I <sub>PD</sub> <sup>(2)</sup>	Power down current	f <sub>CLKIN</sub> = 0 MHz, V <sub>DD</sub> = 3.3 V			20	μA
I <sub>OZ</sub>	Output 3-state	V <sub>o</sub> = 0 V or V <sub>DD</sub> , V <sub>DD</sub> = 3.6 V			±5	μA
C <sub>I</sub>	Input capacitance at FBIN, CLKIN	V <sub>I</sub> = 0 V or V <sub>DD</sub>		4		pF
C <sub>I</sub>	Input capacitance at S1, S2	V <sub>I</sub> = 0 V or V <sub>DD</sub>		2.2		pF
C <sub>O</sub>	Output capacitance	V <sub>I</sub> = 0 V or V <sub>DD</sub>		3		pF
V <sub>OH</sub>	High-level output voltage	V <sub>DD</sub> = min to max, I <sub>OH</sub> = −100 μA	V <sub>DD</sub> − 0.2			V
		V <sub>DD</sub> = 3 V, I <sub>OH</sub> = −12 mA	2.1			
		V <sub>DD</sub> = 3 V, I <sub>OH</sub> = −6 mA	2.4			
V <sub>OL</sub>	Low-level output voltage	V <sub>DD</sub> = min to max, I <sub>OL</sub> = 100 μA			0.2	V
		V <sub>DD</sub> = 3 V, I <sub>OL</sub> = 12 mA			0.8	
		V <sub>DD</sub> = 3 V, I <sub>OL</sub> = 6 mA			0.55	
I <sub>OH</sub>	High-level output current	V <sub>DD</sub> = 3 V, V <sub>O</sub> = 1 V	−24			mA
		V <sub>DD</sub> = 3.3 V, V <sub>O</sub> = 1.65 V		−30		
		V <sub>DD</sub> = 3.6 V, V <sub>O</sub> = 3.135 V		−15		
I <sub>OL</sub>	Low-level output current	V <sub>DD</sub> = 3 V, V <sub>O</sub> = 1.95 V	26			mA
		V <sub>DD</sub> = 3.3 V, V <sub>O</sub> = 1.65 V		33		
		V <sub>DD</sub> = 3.6 V, V <sub>O</sub> = 0.4 V		14		

(1) All typical values are at respective nominal  $V_{DD}$ .

(2) For  $I_{DD}$  over frequency see [Figure 9-2](#).

## 6.6 Timing Requirements

over recommended ranges of supply voltage, load, and operating free-air temperature

		MIN	NOM	MAX	UNIT
Clock frequency, $f_{clk}$	$C_L = 25\text{ pF}$	8		100	MHz
	$C_L = 15\text{ pF}$	66		200	

## 6.7 Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
$t_{\text{lock}}$	PLL lock time	$f = 100 \text{ MHz}$		10		$\mu\text{s}$
$t_{\text{phoffset}}$	Phase offset (CLKIN to FBIN)	$f = 8 \text{ MHz to } 66 \text{ MHz},$ $V_{\text{th}} = V_{\text{DD}}/2$ <sup>(3)</sup>	-200		200	ps
		$f = 66 \text{ MHz to } 200 \text{ MHz},$ $V_{\text{th}} = V_{\text{DD}}/2$ <sup>(3)</sup>	-150		150	
$t_{\text{PLH}}$	Low-to-high level output propagation delay	$S2 = \text{High}, S1 = \text{Low (PLL bypass)},$ $f = 1 \text{ MHz}, C_L = 25 \text{ pF}$	2.5		6	ns
$t_{\text{PHL}}$	High-to-low level output propagation delay		2.5		6	
$t_{\text{sk(o)}}$	Output skew ( $Y_n$ to $Y_n$ ) <sup>(2)</sup>				150	ps
$t_{\text{sk(pp)}}$	Part-to-part skew	$S2 = \text{high}, S1 = \text{high (PLL mode)}$			600	ps
		$S2 = \text{high}, S1 = \text{low (PLL bypass)}$			700	
$t_{\text{jit(cc)}}$	Jitter (cycle-to-cycle)	$f = 66 \text{ MHz to } 200 \text{ MHz}, C_L = 15 \text{ pF}$			$\pm 100$	ps
		$f = 66 \text{ MHz to } 100 \text{ MHz}, C_L = 25 \text{ pF},$ $f = 8 \text{ MHz to } 66 \text{ MHz (see Figure 6-2)}$			$\pm 150$	
odc	Output duty cycle	$f = 8 \text{ MHz to } 200 \text{ MHz}$	43%		57%	
$t_{\text{sk(p)}}$	Pulse skew	$S2 = \text{High}, S1 = \text{low (PLL bypass)},$ $f = 1 \text{ MHz}, C_L = 25 \text{ pF}$			0.7	ns
$t_{\text{RISE}}$	Rise time rate	$C_L = 15 \text{ pF}, \text{ See Figure 7-4}$	0.8		3.3	V/ns
		$C_L = 25 \text{ pF}, \text{ See Figure 7-4}$	0.5		2	
$t_{\text{FALL}}$	Fall time rate	$C_L = 15 \text{ pF}, \text{ See Figure 7-4}$	0.8		3.3	V/ns
		$C_L = 25 \text{ pF}, \text{ See Figure 7-4}$	0.5		2	

(1) All typical values are at respective nominal  $V_{\text{DD}}$ .

(2) The  $t_{\text{sk(o)}}$  specification is only valid for equal loading of all outputs.

(3) Similar waveform at CLKIN and FBIN are required. For phase displacement between CLKIN and Y-outputs see Figure 6-1.

## 6.8 Typical Characteristics

Figure 6-1 captures the variation of the CDCVF25081 current consumption with capacitive load and phase displacement. Figure 6-2 shows the variation of the cycle-to-cycle jitter across frequency.

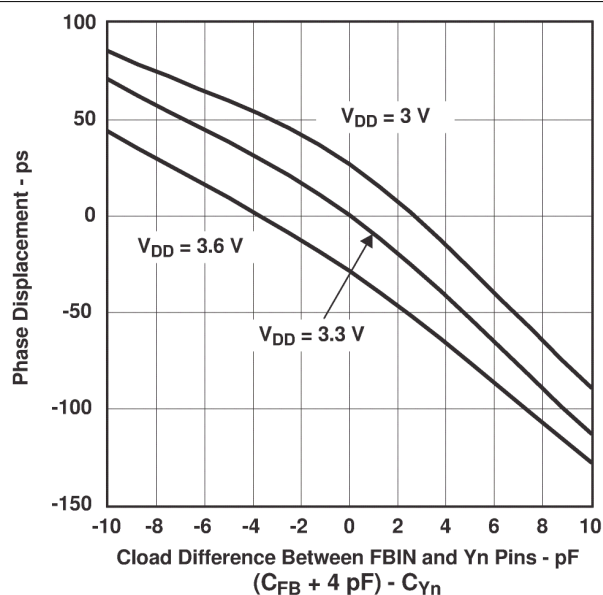


Figure 6-1. Phase Displacement vs. Load

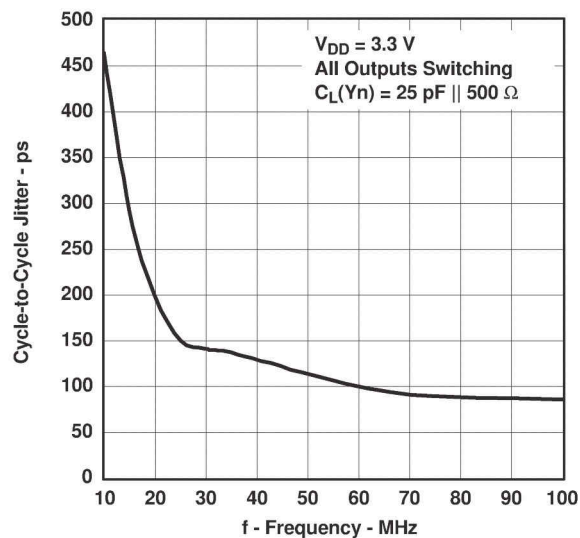
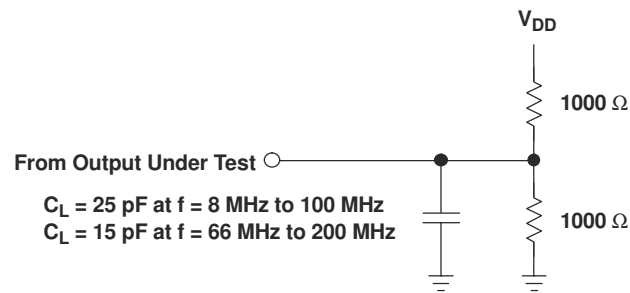


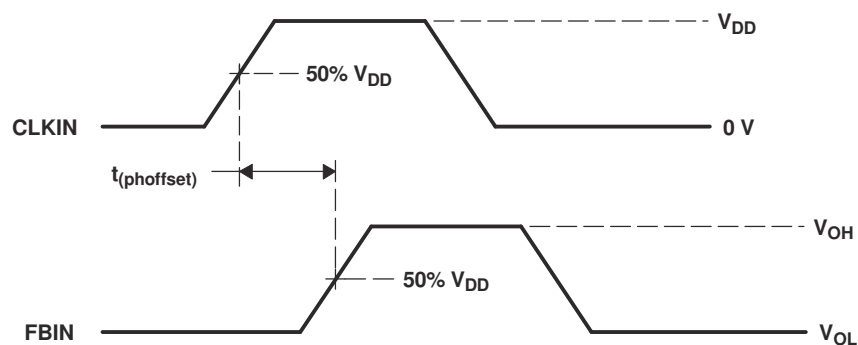
Figure 6-2. Cycle-to-Cycle Jitter vs. Frequency

## 7 Parameter Measurement Information

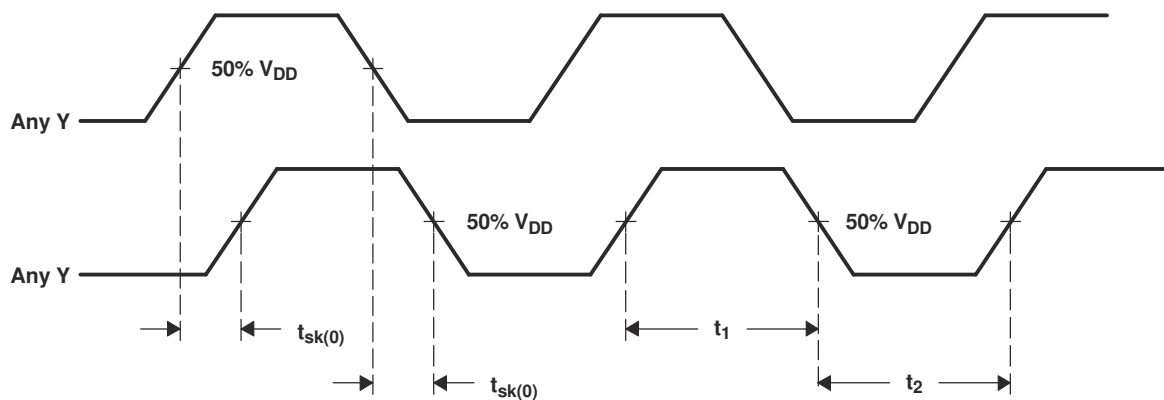


- NOTES: A.  $C_L$  includes probe and jig capacitance.  
 B. All input pulses are supplied by generators having the following characteristics:  $Z_O = 50 \Omega$ ,  $t_r < 1.2 \text{ ns}$ ,  $t_f < 1.2 \text{ ns}$ .  
 C. The outputs are measured one at a time with one transition per measurement.

**Figure 7-1. Test Load Circuit**



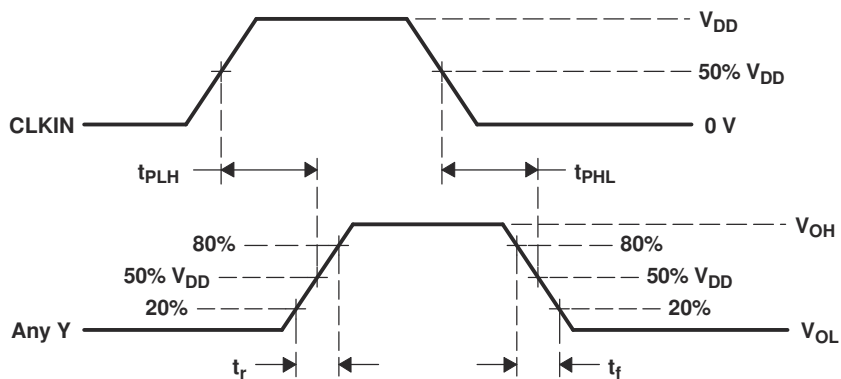
**Figure 7-2. Voltage Thresholds for Measurements, Phase Offset (PLL Mode)**



NOTE:  $\text{odc} = t_1 / (t_1 + t_2) \times 100\%$

**Figure 7-3. Output Skew and Output Duty Cycle (PLL Mode)**





NOTE:  $t_{sk(p)} = |t_{PLH} - t_{PHL}|$

**Figure 7-4. Propagation Delay and Pulse Skew (Non-PLL Mode)**

## 8 Detailed Description

### 8.1 Overview

The CDCVF25081 is a low jitter, low skew, phase-locked loop clock buffer solution. Unlike many products containing PLLs, the CDCVF25081 does not require an external RC network. The loop filter for the PLL is included on-chip, minimizing component count, space, and cost. Two banks of four outputs each provide buffered copies of the CLKIN.

### 8.2 Functional Block Diagram

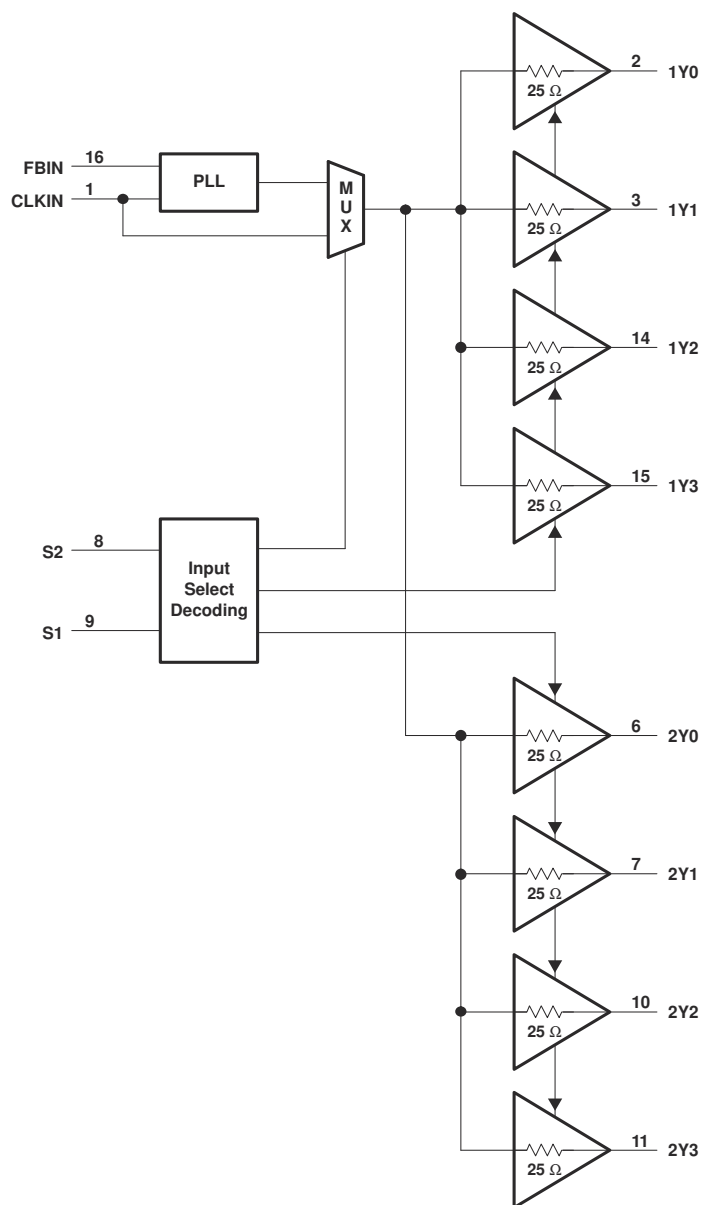


Figure 8-1. Functional Block Diagram

### 8.3 Feature Description

The CDCVF25081 has an integrated PLL with a dedicated feedback pin (FBIN) for synchronization and zero-delay. FBIN must be directly routed to a clock output to complete the feedback loop. When no input is applied to the CLKIN pin, the device powers down the outputs by setting them to a low logic level.

Because it is based on a PLL circuitry, the CDCVF25081 requires a stabilization time to achieve phase lock of the feedback signal to the reference signal. This time is required following power up and application of a fixed-frequency signal at CLKIN and any changes to the PLL reference.

Output duty cycles are adjusted to 50%, independent of duty cycle at CLKIN. Each output has an internal series damping resistor of 25 ohms useful in driving point-to-point loads. Unused outputs can be left floating to reduce overall system cost.

Table 8-1 lists the output bank mapping of the CDCVF25081.

**Table 8-1. Output Bank Mapping**

BANK	CLOCK OUTPUTS
0	1Y0, 1Y1, 1Y2, 1Y3
1	2Y0, 2Y1, 2Y2, 2Y3

### 8.4 Device Functional Modes

The CDCVF25081 operates from a 3.3-V supply. Table 8-2 shows the output logic states of the device based on the selection pins. Based on the input selection pins (S1 and S2), the two output banks can be set as PLL outputs, bypassed PLL outputs, or high impedance.

**Table 8-2. Output Logic Table**

S2	S1	Bank 1	Bank 2	OUTPUT SOURCE	PLL SHUTDOWN
0	0	Hi-Z	Hi-Z	N/A	Yes
0	1	Active	Hi-Z	PLL <sup>(1)</sup>	No
1	0	Active	Active	Input clock (PLL bypass)	Yes
1	1	Active	Active	PLL <sup>(1)</sup>	No

(1) If CLKIN < 2 MHz, then the outputs are switched to a LOW level.

## 9 Application and Implementation

### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 9.1 Application Information

The CDCVF25081 is a low additive jitter, phase-locked loop driver that can operate up to 200 MHz with a 3.3-V supply. The PLL circuitry is internal to device requiring no additional configuration by the user.

### 9.2 Typical Application

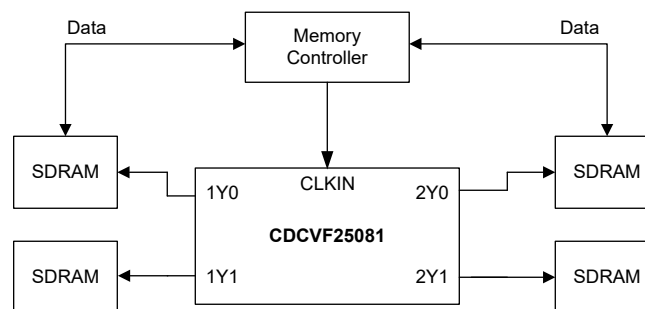


Figure 9-1. System Configuration Example

#### 9.2.1 Design Requirements

Any output pin can be used to synchronize the FBIN to the outputs. TI recommends to not have a load on the output routed to the FBIN pin for optimum results.

#### 9.2.2 Detailed Design Procedure

Unused outputs can be left floating. See the [Power Supply Recommendations](#) section for recommended filtering techniques.

### 9.2.3 Application Curves

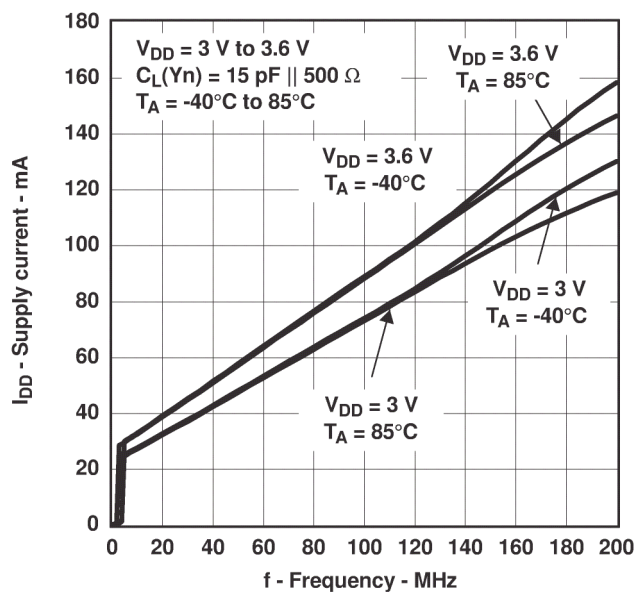


Figure 9-2. Supply Current vs. Frequency

## 10 Power Supply Recommendations

High-performance clock buffers can be sensitive to noise on the power supply, which may dramatically increase the additive jitter of the buffer. Thus, it is essential to manage any excessive noise from the system power supply, especially for applications where the jitter and phase noise performance is critical.

Filter capacitors are used to eliminate the low-frequency noise from the power supply, where the bypass capacitors provide the very low impedance path for high-frequency noise and guard the power supply system against induced fluctuations. These bypass capacitors also provide instantaneous current surges as required by the device and should have low equivalent series resistance (ESR). To properly bypass the supply, the decoupling capacitors must be placed very close to the power-supply terminals, be connected directly to the ground plane, and laid out with short loops to minimize inductance. TI recommends adding as many high-frequency (for example, 0.1  $\mu\text{F}$ ) bypass capacitors, as there are supply terminals in the package. TI recommends, but does not require, inserting a ferrite bead between the board power supply and the chip power supply that isolates the high-frequency switching noises generated by the clock buffer. These beads prevent the switching noise from leaking into the board supply. It is imperative to choose an appropriate ferrite bead with very low DC resistance to provide adequate isolation between the board supply and the chip supply, as well as to maintain a voltage at the supply terminals that is greater than the minimum voltage required for proper operation.

Figure 10-1 shows the recommended power supply decoupling method.

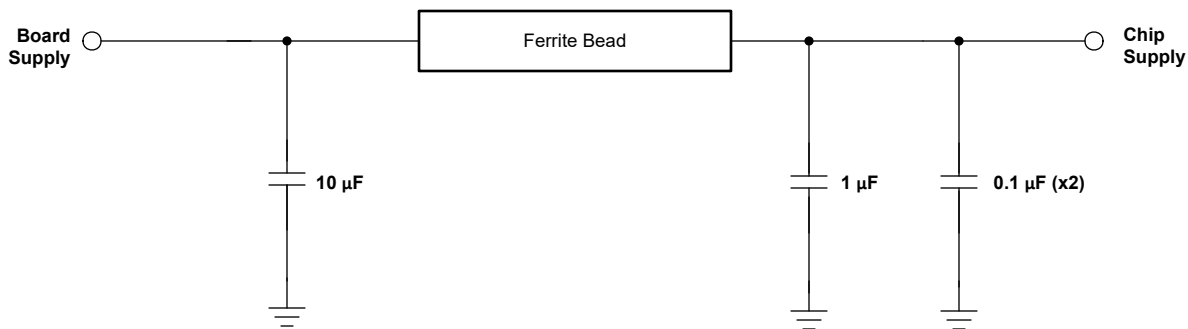


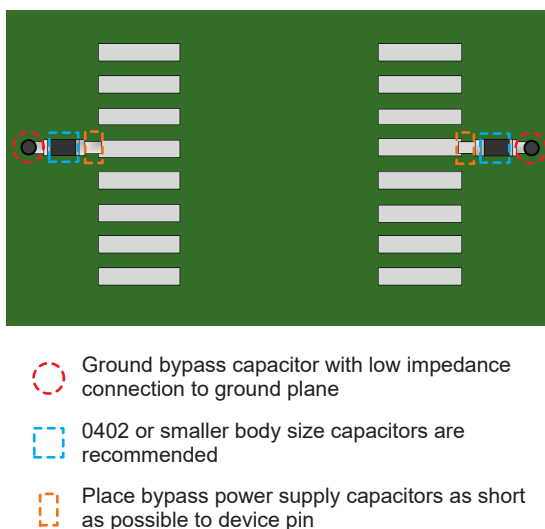
Figure 10-1. Power Supply Decoupling

## 11 Layout

### 11.1 Layout Guidelines

Figure 11-1 shows a conceptual layout detailing recommended placement of power-supply bypass capacitors. For component side mounting, use 0402 body size capacitors to facilitate signal routing. Keep the connections between the bypass capacitors and the power supply on the device as short as possible. Ground the other side of the capacitor using a low-impedance connection to the ground plane.

### 11.2 Layout Example



**Figure 11-1. PCB Conceptual Layout**

## 12 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

### 12.1 Documentation Support

#### 12.1.1 Related Documentation

### 12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](http://ti.com). Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 12.3 Support Resources

TI E2E™ [support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

### 12.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

### 12.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 12.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



## PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">CDCVF25081D</a>	Active	Production	SOIC (D)   16	40   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKV25081
<a href="#">CDCVF25081DR</a>	Active	Production	SOIC (D)   16	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKV25081
<a href="#">CDCVF25081PW</a>	Active	Production	TSSOP (PW)   16	90   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CK081
CDCVF25081PW.A	Active	Production	TSSOP (PW)   16	90   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CK081
CDCVF25081PWG4	Active	Production	TSSOP (PW)   16	90   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CK081
<a href="#">CDCVF25081PWR</a>	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CK081
CDCVF25081PWR.A	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CK081
CDCVF25081PWRG4	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CK081

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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## TAPE AND REEL INFORMATION



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCVF25081DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CDCVF25081PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCVF25081DR	SOIC	D	16	2500	350.0	350.0	43.0
CDCVF25081PWR	TSSOP	PW	16	2000	353.0	353.0	32.0

## TUBE



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
CDCVF25081D	D	SOIC	16	40	505.46	6.76	3810	4
CDCVF25081PW	PW	TSSOP	16	90	530	10.2	3600	3.5
CDCVF25081PW.A	PW	TSSOP	16	90	530	10.2	3600	3.5
CDCVF25081PWG4	PW	TSSOP	16	90	530	10.2	3600	3.5

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - $\triangle C$  Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
  - $\triangle D$  Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
  - E. Reference JEDEC MS-012 variation AC.



## PACKAGE OUTLINE

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

# EXAMPLE BOARD LAYOUT

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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